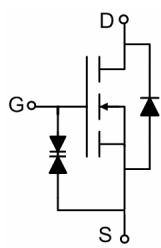
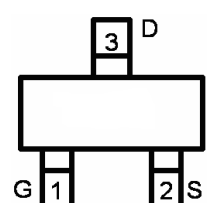



N-Channel Enhancement Mode Power MOSFET

<p>General Features</p> <ul style="list-style-type: none"> ● $V_{DS} = 30V, I_D = 0.2A$ ● $R_{DS(ON)} < 4\Omega @ V_{GS}=4.5V$ ● $R_{DS(ON)} < 8\Omega @ V_{GS}=2.5V$ ● ESD Rating: HBM 2300V <p>● High power and current handing capability</p> <p>● Lead free product is acquired</p> <p>● Surface mount package</p> <p>Application</p> <ul style="list-style-type: none"> ● Direct logic-level interface: TTL/CMOS ● Drivers: relays, solenoids, lamps, hammers, display, memories, transistors, etc. ● Battery operated systems ● Solid-state relays 	 <p style="text-align: center;">Schematic diagram</p>  <p style="text-align: center;">Marking and pin assignment</p>  <p style="text-align: center;">SOT-323 top view</p>
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Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	±20	V
Drain Current-Continuous	I_D	0.2	A
Drain Current-Pulsed (Note 1)	I_{DM}	0.58	A
Maximum Power Dissipation	P_D	0.35	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 150	°C

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2)	R _{θJA}	350	°C/W
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Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	30	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=30V, V_{GS}=0V$	-	-	1	μA

Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 10V, V_{DS}=0V$	-	-	± 500	nA
		$V_{GS}=\pm 12V, V_{DS}=0V$	-	-	± 10	μA
On Characteristics (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.8	1.1	1.5	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=4.5V, I_D=0.2A$	-	2	4	Ω
		$V_{GS}=2.5V, I_D=0.1A$	-	4	8	Ω
Forward Transconductance	g_{FS}	$V_{DS}=10V, I_D=0.2A$	0.2	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C_{iss}	$V_{DS}=20V, V_{GS}=0V,$ $F=1.0MHz$	-	30	-	PF
Output Capacitance	C_{oss}		-	15	-	PF
Reverse Transfer Capacitance	C_{rss}		-	6	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=20V, I_D=0.2A$ $V_{GS}=10V, R_{GEN}=6\Omega$	-	-	5	nS
Turn-on Rise Time	t_r		-	-	5	nS
Turn-Off Delay Time	$t_{d(off)}$		-	-	60	nS
Turn-Off Fall Time	t_f		-	-	35	nS
Total Gate Charge	Q_g	$V_{DS}=20V, I_D=0.2A,$ $V_{GS}=10V$	-	-	2.4	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V_{SD}	$V_{GS}=0V, I_S=0.2A$	-	-	1.3	V
Diode Forward Current (Note 2)	I_S		-	-	0.2	A

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production

Typical Electrical and Thermal Characteristics

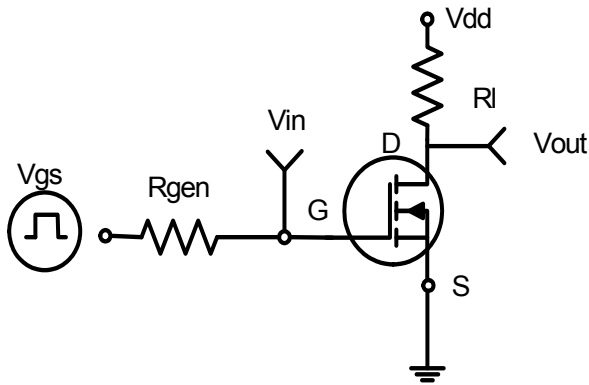


Figure 1: Switching Test Circuit

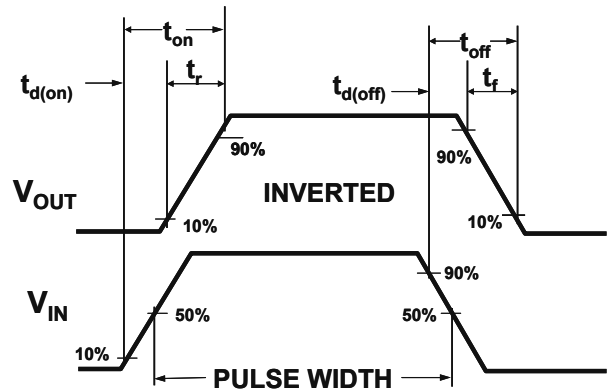


Figure 2: Switching Waveforms

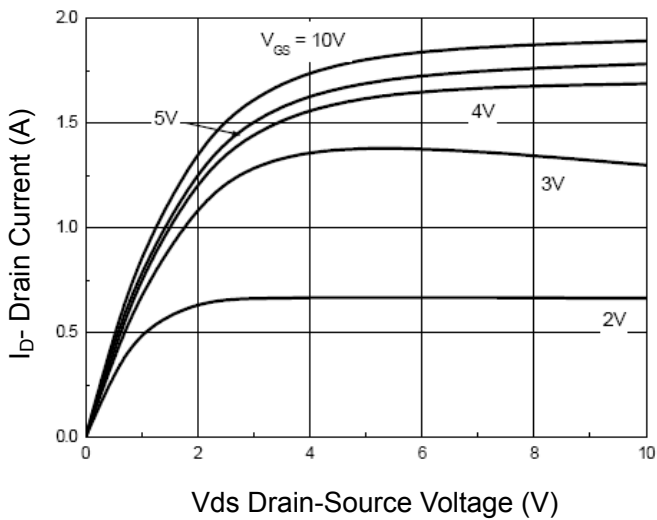


Figure 3 Output CHARACTERISTICS

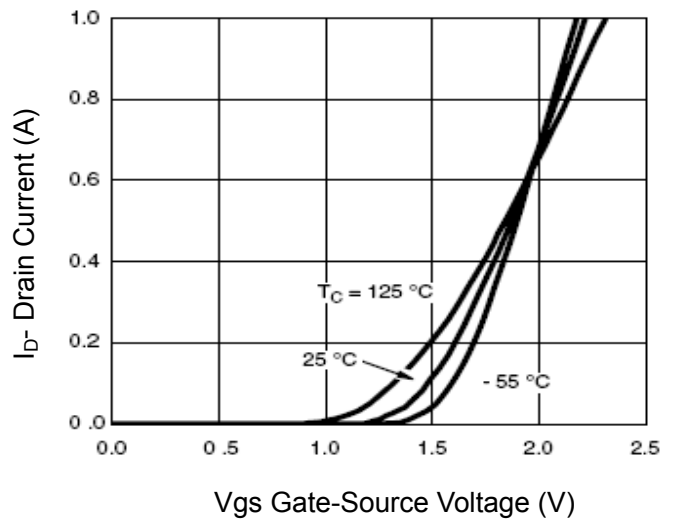


Figure 4 Transfer Characteristics

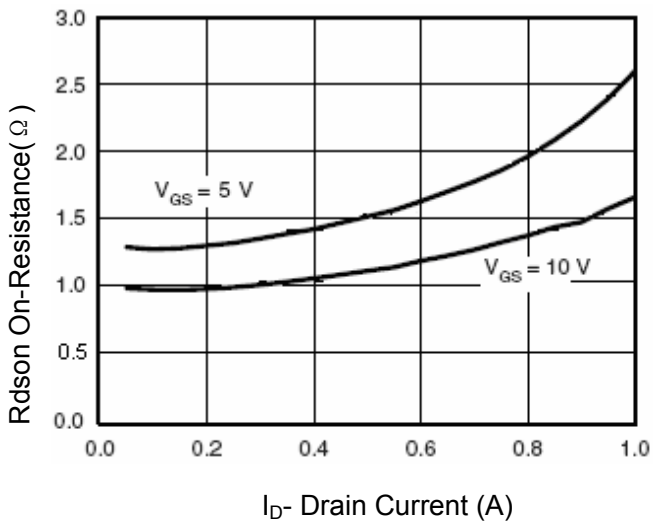


Figure 5 Drain-Source On-Resistance

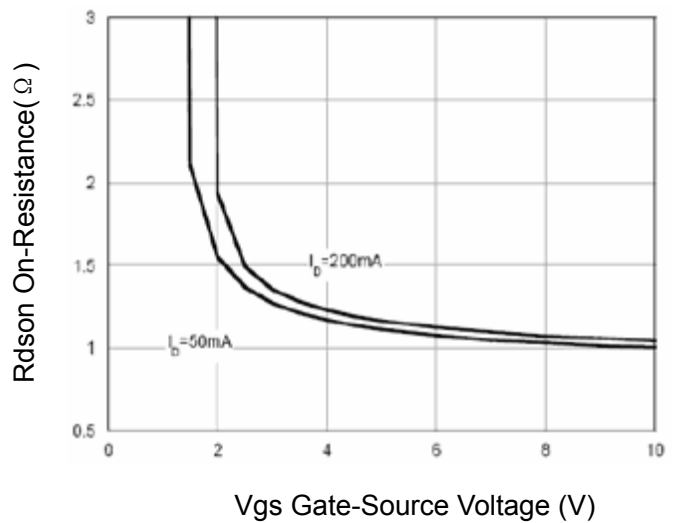
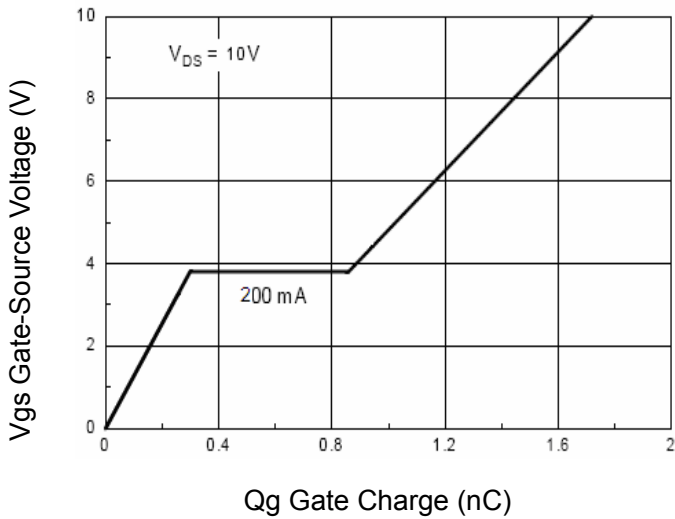
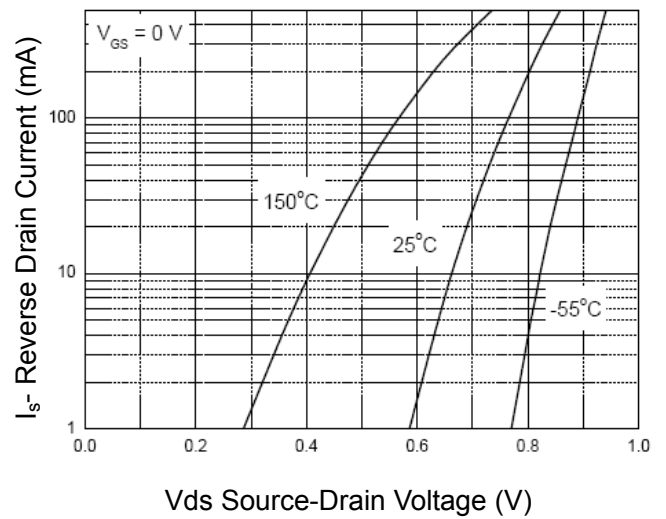


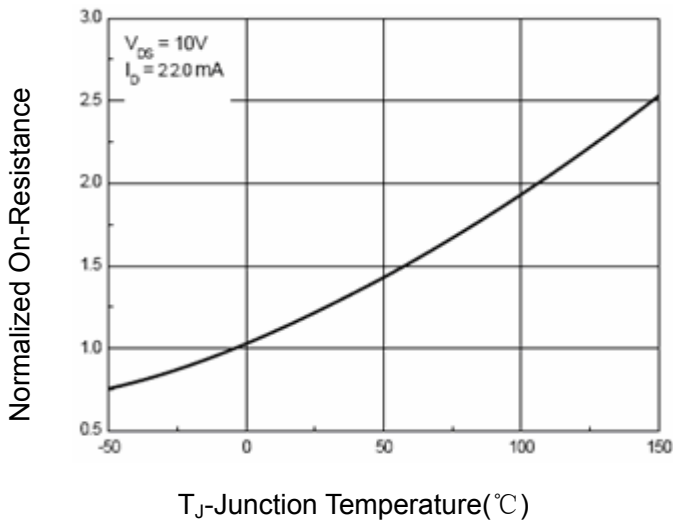
Figure 6 Rds(on) vs Vgs



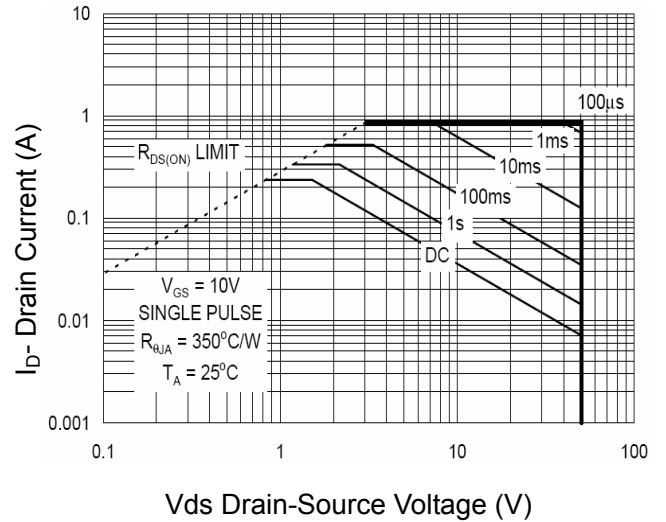
Qg Gate Charge (nC)
Figure 7 Gate Charge



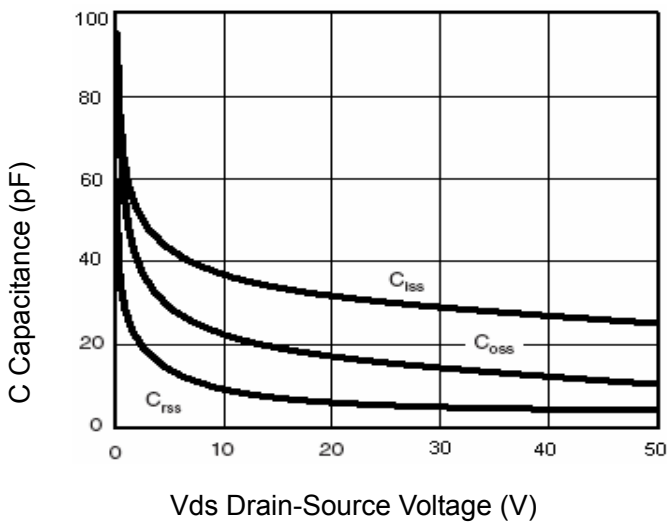
Vds Source-Drain Voltage (V)
Figure 8 Source-Drain Diode Forward



TJ-Junction Temperature(°C)
Figure 9 Drain-Source On-Resistance



Vds Drain-Source Voltage (V)
Figure 10 Safe Operation Area



Vds Drain-Source Voltage (V)
Figure 11 Capacitance vs Vds

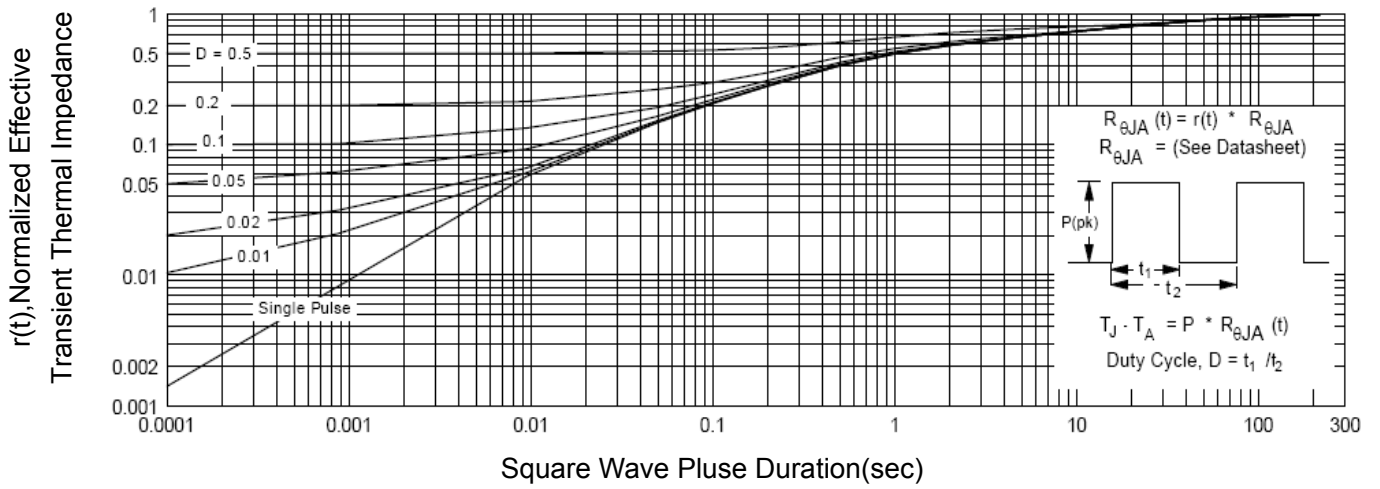
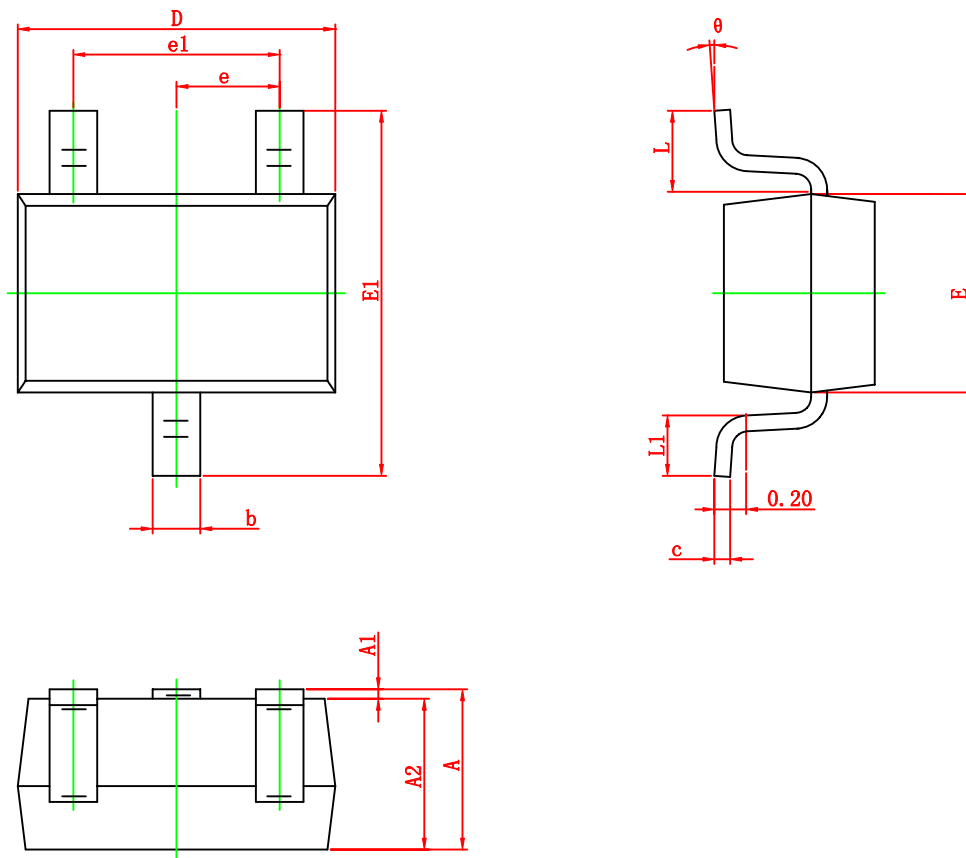


Figure 12 Normalized Maximum Transient Thermal Impedance

Package outline dimensions

SOT-323



Symbol	Dimensions in millimeter		
	Min.	Typ.	Max.
A	0.900	1.000	1.100
A1	0.000	0.050	0.100
A2	0.900	0.950	1.000
b	0.200	0.300	0.400
c	0.080	0.115	0.150
D	2.000	2.100	2.200
E	1.150	1.250	1.350
E1	2.150	2.300	2.450
e	0.650TYP		
e1	1.200	1.300	1.400
L	0.525REF		
L1	0.260		0.460
theta	0°		8°